## N-Channel 55 V (D-S) MOSFET

| $\mathrm{V}_{\mathrm{DS}}(\mathrm{V})$ | $\mathrm{R}_{\mathrm{DS} \text { (on) }}(\Omega)$ | $I_{D}(A)^{\text {d }}$ | $Q_{g}$ (Typ.) |
| :---: | :---: | :---: | :---: |
| 55 | 0.0052 at $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 100 | 79 |

## FEATURES

- DT-Trench Power MOSFET
- $100 \% \mathrm{R}_{\mathrm{g}}$ and UIS Tested
- Compliant to RoHS Directive 2002/95/EC


## APPLICATIONS

- Power Supply
- Secondary Synchronous Rectification
- DC/DC Converter


| ABSOLUTE MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$, unless otherwise noted) |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| Parameter |  | Symbol | Limit | Unit |
| Drain-Source Voltage |  | $V_{\text {DS }}$ | 55 | V |
| Gate-Source Voltage |  | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 20$ |  |
| Continuous Drain Current ( $\mathrm{T}_{J}=150{ }^{\circ} \mathrm{C}$ ) | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | $100^{\text {d }}$ | A |
|  | $\mathrm{T}_{\mathrm{C}}=70^{\circ} \mathrm{C}$ |  | $80^{\text {d }}$ |  |
| Pulsed Drain Current |  | $\mathrm{I}_{\text {DM }}$ | 300 |  |
| Avalanche Current |  | $\mathrm{I}_{\text {AS }}$ | 50 |  |
| Single Avalanche Energy ${ }^{\text {a }}$ | $\mathrm{L}=0.1 \mathrm{mH}$ | $\mathrm{E}_{\text {AS }}$ | 170 | mJ |
| Maximum Power Dissipation ${ }^{\text {a }}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | $125^{\text {b }}$ | W |
|  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}^{\mathrm{C}}$ |  | 3.0 |  |
| Operating Junction and Storage Temperature Range |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | - 55 to 150 | ${ }^{\circ} \mathrm{C}$ |

## THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Limit | Unit |
| :--- | :---: | :---: | :---: |
| Junction-to-Ambient (PCB Mount) ${ }^{c}$ | $\mathrm{R}_{\text {thJA }}$ | 40 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Junction-to-Case (Drain) $\quad \mathrm{R}_{\text {thJC }}$ | 1 |  |  |

Notes:
a. Duty cycle $\leq 1 \%$.
b. See SOA curve for voltage derating
c. When mounted on 1" square PCB (FR-4 material).
d. Package limited.

| SPECIFICATIONS ( $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$, unless otherwise noted) |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
| Static |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | $\mathrm{V}_{\mathrm{DS}}$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 55 |  |  | V |
| Gate Threshold Voltage | $\mathrm{V}_{\mathrm{GS} \text { (th) }}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 1 |  | 4 |  |
| Gate-Body Leakage | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ |  |  | $\pm 250$ | nA |
| Zero Gate Voltage Drain Current | IDSS | $\mathrm{V}_{\mathrm{DS}}=55 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  | 1 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=55 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  |  | 50 |  |
|  |  | $\mathrm{V}_{\mathrm{DS}}=55 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=150{ }^{\circ} \mathrm{C}$ |  |  | 250 |  |
| On-State Drain Current ${ }^{\text {a }}$ | $\mathrm{I}_{\mathrm{D} \text { (on) }}$ | $\mathrm{V}_{\mathrm{DS}} \geq 10 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 50 |  |  | A |
| Drain-Source On-State Resistance ${ }^{\text {a }}$ | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}$ |  | 0.0052 | 0.0058 | $\Omega$ |
| Forward Transconductance ${ }^{\text {a }}$ | $\mathrm{gfs}^{\text {f }}$ | $V_{D S}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=20 \mathrm{~A}$ |  | 159 |  | S |
| Dynamic ${ }^{\text {b }}$ |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=20 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |  | 3286 |  | pF |
| Output Capacitance | Coss |  |  | 705 |  |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  |  | 283 |  |  |
| Total Gate Charge ${ }^{\text {c }}$ | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{DS}}=20 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=20 \mathrm{~A}$ |  | 87 | 131 | nC |
| Gate-Source Charge ${ }^{\text {c }}$ | $Q_{\text {gs }}$ |  |  | 15.3 |  |  |
| Gate-Drain Charge ${ }^{\text {c }}$ | $\mathrm{Q}_{\mathrm{gd}}$ |  |  | 12.2 |  |  |
| Gate Resistance | $\mathrm{R}_{\mathrm{g}}$ | $\mathrm{f}=1 \mathrm{MHz}$ | 0.5 | 2.7 | 5.4 | $\Omega$ |
| Turn-On Delay Time ${ }^{\text {c }}$ | $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{DD}}=20 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=2 \Omega \\ \mathrm{I}_{\mathrm{D}} \cong 10 \mathrm{~A}, \mathrm{~V}_{\mathrm{GEN}}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{g}}=1 \Omega \end{gathered}$ |  | 11 | 20 | ns |
| Rise Time ${ }^{\text {c }}$ | $t_{r}$ |  |  | 7 | 14 |  |
| Turn-Off Delay Time ${ }^{\text {c }}$ | $\mathrm{t}_{\mathrm{d} \text { (off) }}$ |  |  | 45 | 68 |  |
| Fall Time ${ }^{\text {c }}$ | $t_{f}$ |  |  | 7 | 14 |  |
| Drain-Source Body Diode Ratings and Characteristics $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ b |  |  |  |  |  |  |
| Continuous Current | $\mathrm{I}_{s}$ |  |  |  | 90 | A |
| Pulsed Current | $\mathrm{I}_{\text {SM }}$ |  |  |  | 300 |  |
| Forward Voltage ${ }^{\text {a }}$ | $V_{S D}$ | $\mathrm{F}=10 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | 0.72 | 1.2 | V |
| Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~A}, \mathrm{dl} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ |  | 42 | 63 | ns |
| Peak Reverse Recovery Current | $I_{\text {RM(REC })}$ |  |  | 2.5 | 3.8 | A |
| Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{rr}}$ |  |  | 52 | 78 | nC |
| Notes: <br> a. Pulse test; pulse width $\leq 300 \mu \mathrm{~s}$, duty cycle $\leq 2 \%$. <br> b. Guaranteed by design, not subject to production testing. <br> c. Independent of operating temperature. |  |  |  |  |  |  |

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress rating sonly, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS $\left(25^{\circ} \mathrm{C}\right.$, unless otherwise noted)



Transfer Characteristics


Transconductance


On-Resistance vs. Drain Current


On-Resistance vs. Gate-to-Source Voltage


Gate Charge

TYPICAL CHARACTERISTICS $\left(25^{\circ} \mathrm{C}\right.$, unless otherwise noted)


Source-Drain Diode Forward Voltage


Capacitance


On-Resistance vs. Junction Temperature



Drain Source Breakdown vs. Junction Temperature


Current Derating

## TO-263 PACKAGE OUTLINE



## COMMON DIMENSIONS <br> (UNITS OF MEASURE=MILLIMETER)

| SYMBOL | MIN | TYP | MAX | SYMBOL | MIN | TYP | MAX |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A | 4.10 | 4.50 | 4.80 | e | 2.35 | 2.54 | 2.75 |  |  |  |  |  |  |  |
| A1 | 0.00 | 0.10 | 0.30 | e 1 | 5.08 REF |  |  |  |  |  |  |  |  |  |
| A2 | 1.10 | 1.30 | 1.50 | H | 14.50 | 15.15 | 16.00 |  |  |  |  |  |  |  |
| A3 | 2.15 | 2.50 | 3.10 | H 1 | 1.00 | 1.28 | 1.75 |  |  |  |  |  |  |  |
| b | 0.60 | 0.80 | 1.05 | L | 1.80 | 2.23 | 2.90 |  |  |  |  |  |  |  |
| b1 | 1.05 | 1.33 | 1.50 | L 1 | 4.30 | 4.75 | 5.50 |  |  |  |  |  |  |  |
| c | 0.33 | 0.50 | 0.66 | L 2 | 1.00 | 1.30 | 1.85 |  |  |  |  |  |  |  |
| D | 8.40 | 9.20 | 9.60 | L 3 | 0.90 | 4.65 | 9.00 |  |  |  |  |  |  |  |
| D1 | 7.50 REF |  |  |  |  |  |  |  |  |  | $\phi$ | $0^{\circ}$ | $2^{\circ}$ | $5^{\circ}$ |
| E | 9.60 | 10.02 | 10.80 | $\phi 1$ | $2^{\circ}$ | - | $7^{\circ}$ |  |  |  |  |  |  |  |
| E1 | 7.60 | 9.88 | 10.30 | $\Phi$ | 1.5 BSC |  |  |  |  |  |  |  |  |  |

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